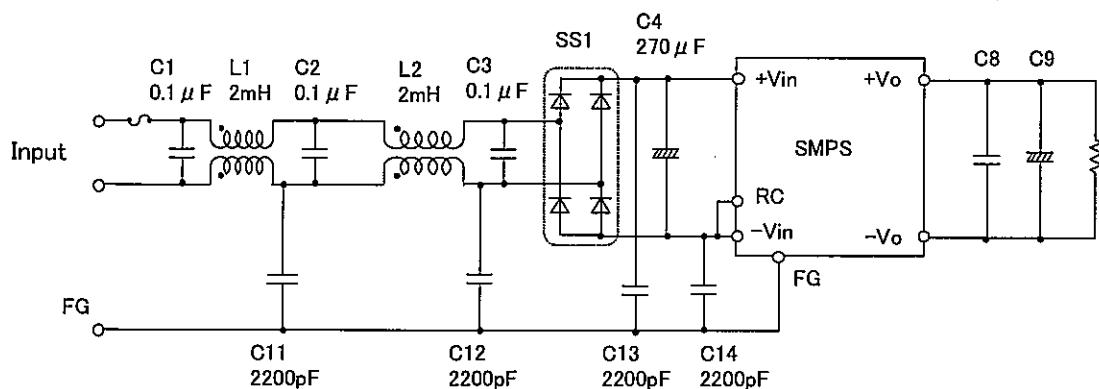


DHS50A series EMI/EMS Test resultApproved : *Tatsuya Mano*  
Tatsuya ManoPrepared : *Tetsuro Hirata*  
Tetsuro Hirata

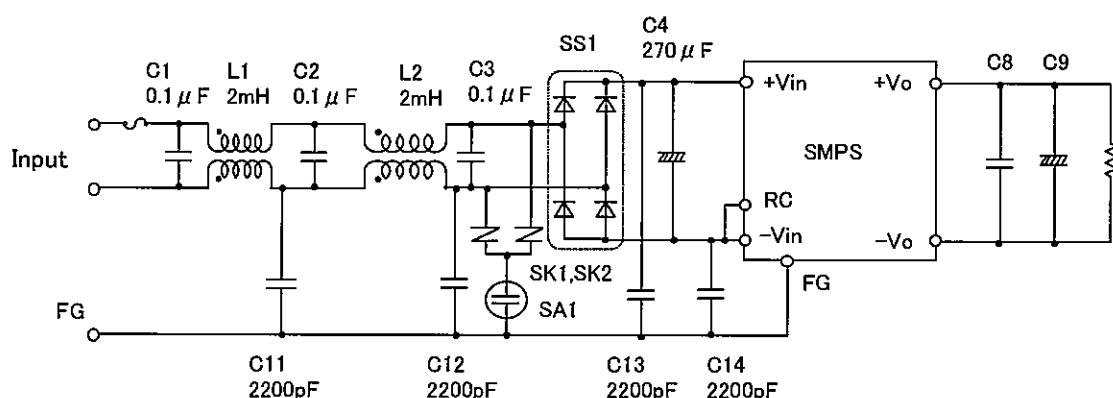
| No. | Test item   | Conditions   | Conditions of Acceptability   | Result |
|-----|---|--|---|--------|
| 1   | Line conduction   | (1) Rated input(DC110V/AC90V)<br>(2) Rated load<br>(3) Ambient temp. $25 \pm 10^\circ\text{C}$<br>(4) Testing circuitry Fig.1  | (1)Meets the undermentioned standard.<br>FCC Part15 classA , VCCI classA<br>CISPR11 classA , EN55011-A  | OK     |
| 2   | Radiated emission   | (1) Rated input(DC110V/AC90V)<br>(2) Rated load<br>(3) Ambient temp. $25 \pm 10^\circ\text{C}$<br>(4) Testing circuitry Fig.1  | (1)Meets the undermentioned standard.<br>FCC Part15 classA , VCCI classA<br>CISPR11 classA , EN55011-A  | OK     |
| 3   | Static electricity immunity test<br>(EN61000-4-2)   | (1) Rated input(DC110V/AC90V)<br>(2) Rated load<br>(3) Ambient temp. $25 \pm 10^\circ\text{C}$<br>(4) Contact discharge voltage 8[kV]<br>(EN61000-4-2 Level 4)<br>(5) Testing circuitry Fig.1                      | (1)No protection circuit failure.<br>(2)No output voltage drop with control circuit failure.<br>(3)No any other function failure                        | OK     |
| 4   | Radiated, radio-frequency,<br>electromagnetic field immunity test<br>(EN61000-4-3)        | (1) Rated input(DC110V/AC90V)<br>(2) Rated load<br>(3) Ambient temp. $25 \pm 10^\circ\text{C}$<br>(4)Testing field strength 10[V/m]<br>(EN61000-4-3 Level 3)<br>(5) Testing circuitry Fig.1                        | (1)No protection circuit failure.<br>(2)No output voltage drop with control circuit failure.<br>(3)No any other function failure                        | OK     |
| 5   | Electrical fast transient/<br>burst immunity test<br>(EN61000-4-4)                        | (1) Rated input(DC110V/AC90V)<br>(2) Rated load<br>(3) Ambient temp. $25 \pm 10^\circ\text{C}$<br>(4) Test peak voltage 4[kV]<br>(IEC61000-4-4 Level 4)<br>(5) Testing circuitry Fig.1                             | (1)No protection circuit failure.<br>(2)No output voltage drop with control circuit failure.<br>(3)No any other function failure                        | OK     |
| 6   | Surge immunity test<br>(EN61000-4-5)  | (1) Rated input(DC110V/AC90V)<br>(2) Rated load<br>(3) Ambient temp. $25 \pm 10^\circ\text{C}$<br>(4) Test voltage<br>Line to line 2[kV] (Level 3)<br>Line to earth 4[kV] (Level 4)<br>(5) Testing circuitry Fig.2 | (1)The power supply is not stop<br>(2)Circuit does not malfunction.<br>(3)No abnormality of the insulation destruction etc.<br>(4)Parts are no damaged. | OK     |
| 7   | Immunity to conducted disturbances,<br>induced by radio-frequency fields<br>(EN61000-4-6) | (1) Rated input(DC110V/AC90V)<br>(2) Rated load<br>(3) Ambient temp. $25 \pm 10^\circ\text{C}$<br>(4) Voltage level (e.m.f.) 10[V]<br>(Level 3)<br>(5) Testing circuitry Fig.1                                     | (1)No protection circuit failure.<br>(2)No output voltage drop with control circuit failure.<br>(3)No any other function failure                        | OK     |

COSEL



L1,L2 : SC-05-200(NEC TOKIN)  
 SS1 : D3SBA60(SINDENGEN)  
 C8 : DHS50A24/DHS100A24 4.7  $\mu$  F  
 Others 10  $\mu$  F  
 C9 : DHS50A05/DHS100A05 2200  $\mu$  F  
 DHS50A12/DHS100A12 470  $\mu$  F  
 DHS50A15/DHS100A15 470  $\mu$  F  
 DHS50A24/DHS100A24 220  $\mu$  F

Fig.1 Testing circuitry



L1,L2 : SC-05-200(NEC TOKIN)  
 SS1 : D3SBA60(SINDENGEN)  
 SK1,SK2 : ENE471D-10A(FUJI ELECTRIC CO.,LTD)  
 SA1 : DSA-302MA(MITSUBISHI MATERIALS COAP.)  
 C8 : DHS50A24/DHS100A24 4.7  $\mu$  F  
 Others 10  $\mu$  F  
 C9 : DHS50A05/DHS100A05 2200  $\mu$  F  
 DHS50A12/DHS100A12 470  $\mu$  F  
 DHS50A15/DHS100A15 470  $\mu$  F  
 DHS50A24/DHS100A24 220  $\mu$  F

Fig.2 Surge immunity Testing circuitry